

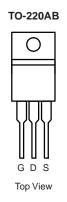
### TSM8N80CZ C0-VB Datasheet

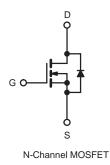
### N-Channel 800V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	800			
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	1.2		
Q <sub>g</sub> (Max.) (nC)	200			
Q <sub>gs</sub> (nC)	24			
Q <sub>gd</sub> (nC)	110			
Configuration	Single			

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	800	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	5		
		T <sub>C</sub> = 100 °C		3.9	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	21		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	770	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	7.8	A	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation T <sub>C</sub> = 25 °C			PD	190	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	-	300 <sup>d</sup>		
Marinatina Tanana	6-32 or M3 screw			10	lbf ∙ in	
Mounting Torque				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V<sub>DD</sub> = 50 V, starting T<sub>J</sub> = 25 °C, L = 23 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 7.8 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  7.8 A, dl/dt  $\leq$  140 A/µs, V<sub>DD</sub>  $\leq$  600 V, T<sub>J</sub>  $\leq$  150 °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

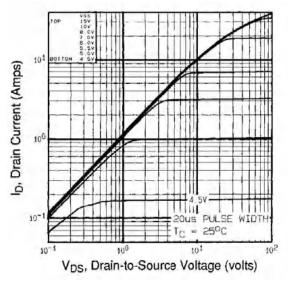


THERMAL RESISTANCE RATII	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 40   0.24 -   - 0.65			°C/W			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>							
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>							
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u	nless otherwi	ise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static							<b>I</b>	1
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> =	250 µA	800	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>		= V <sub>GS</sub> , I <sub>D</sub> =		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20$	V	-	-	± 100	nA
		$V_{DS} = 800 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	100		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 640 \	/, V <sub>GS</sub> = 0 V	V, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	١ <sub>c</sub>	<sub>D</sub> = 3.7 A <sup>b</sup>	-	1.2	-	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =	= 100 V, I <sub>D</sub> =	= 3.7 A <sup>b</sup>	5.6	-	-	S
Dynamic						•	•	
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 \	1	-	3100	-	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0.V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	800	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	490	-		
Total Gate Charge	Qg				-	-	200	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	-	24	nC	
Gate-Drain Charge	Q <sub>gd</sub>		300 1	ig. o and to	-	-	110	1
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-	
Rise Time	t <sub>r</sub>	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{DD} = 400 \; {\sf V}, \; {\sf I}_{D} = 3.8 \; {\sf A}, \\ {\sf R}_{g} = 6.2 \; \Omega, \; {\sf R}_{D} = 52 \; \Omega \\ {\sf see \; fig. \; 10^{b}} \end{array}$		-	38	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	120	-		
Fall Time	t <sub>f</sub>			-	39	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	- nH	
Internal Source Inductance	L <sub>S</sub>			-	13	-		
Drain-Source Body Diode Characteristic	S					•	•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	21		
Body Diode Voltage	V <sub>SD</sub>	$T_{J} = 25 \text{ °C}, I_{S} = 3.8 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.8 A, dl/dt = 100 A/μs <sup>b</sup>		-	650	980	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.8	5.7	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn			-on is dor	ninated h	v Ls and	L <sub>D</sub> )

#### Notes

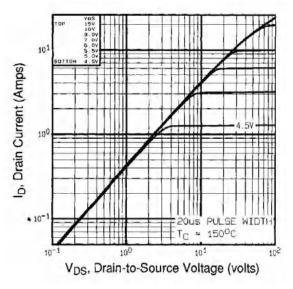
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







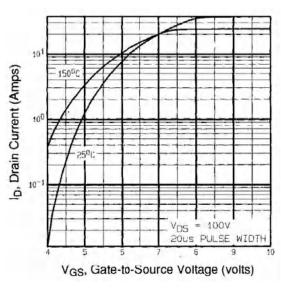
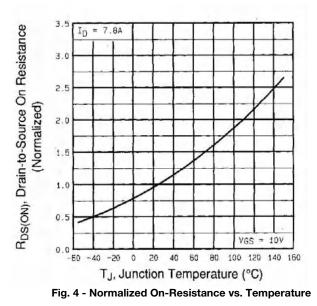


Fig. 3 - Typical Transfer Characteristics



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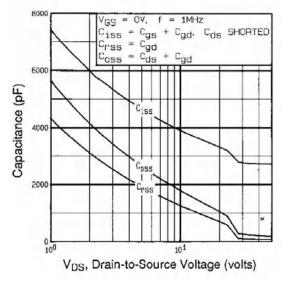


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

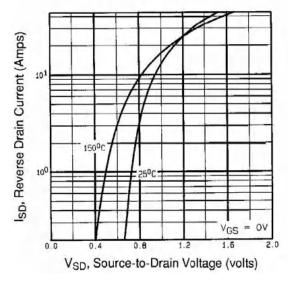


Fig. 7 - Typical Source-Drain Diode Forward Voltage

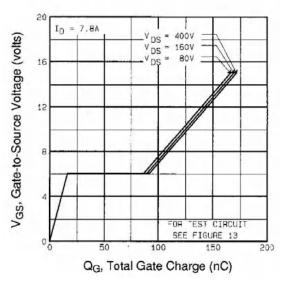
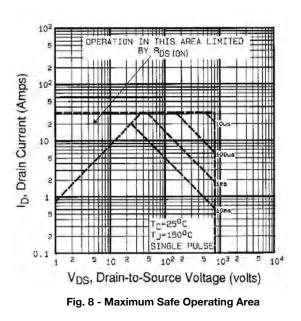


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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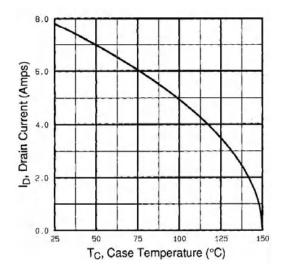


Fig. 9 - Maximum Drain Current vs. Case Temperature

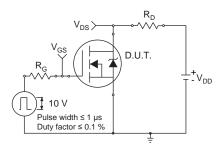


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

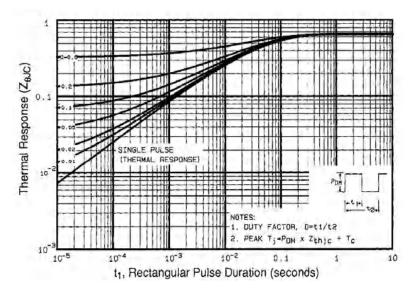


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



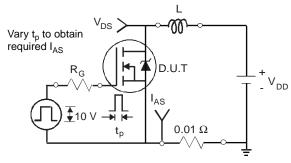


Fig. 12a - Unclamped Inductive Test Circuit

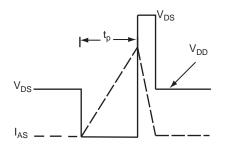


Fig. 12b - Unclamped Inductive Waveforms

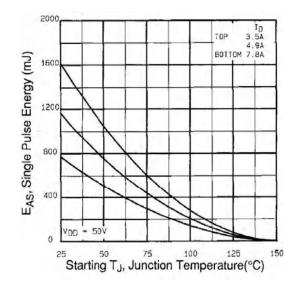


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

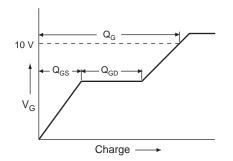
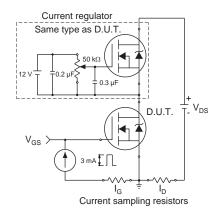


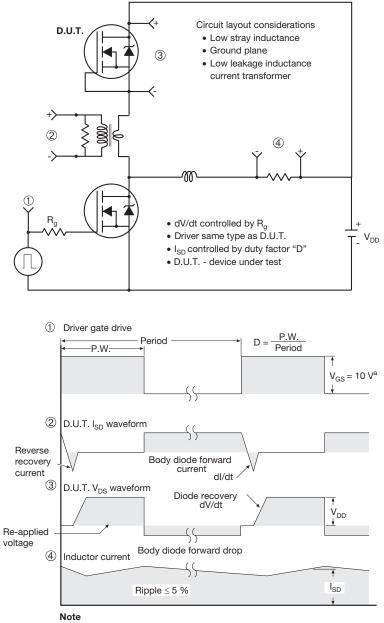
Fig. 13a - Basic Gate Charge Waveform







Peak Diode Recovery dV/dt Test Circuit

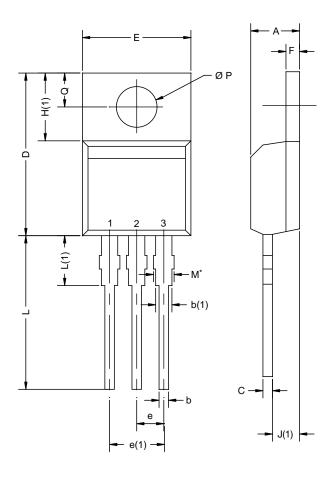


a.  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
E	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471						

#### Notes

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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